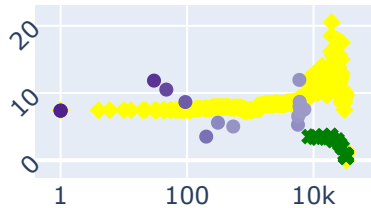
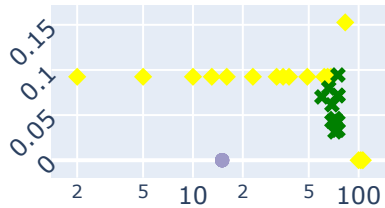


test loss

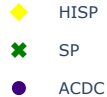
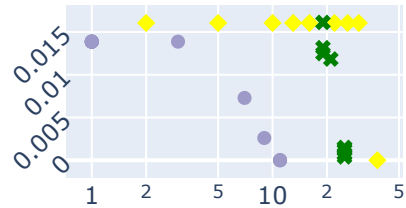
Circuit Recovery (IOI)



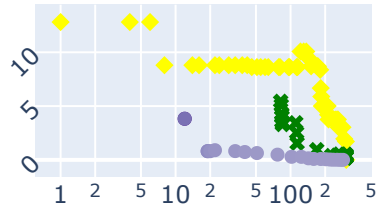
Tracr (Reverse)



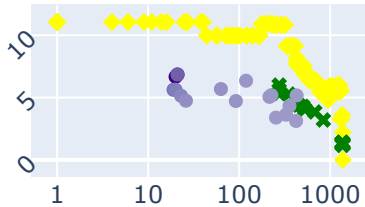
Tracr (Proportion)



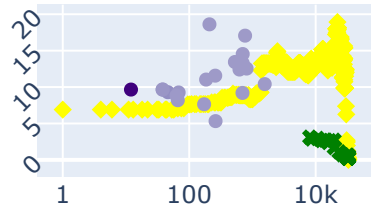
Induction



Docstring



Greater Than



Number of edges